

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10606659	WANG ET AL.
	Examiner	Art Unit
	IZUNNA OKEKE	2432

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
Classification + Keyword search (See History)	10/17/2008	IO
Text Search (See History)	10/18/2008	IO
Search (726/23, 726/24, 726/25) (See History)	10/18/2008	IO
NPL Search (Hashing)	10/16/2008	IO

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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